Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/647,477	VERBIST ET AL.	
Examiner	Art Unit	
.Henry K. Choe	2817	

	SEARCHED			
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Tel sol (Fast) See attachment	12/6/as	Hic	
See attachment  NPL  (IEEE)  See attachment	/,	1)	